
**Optics and photonics — Lasers
and laser-related equipment —
Cavity ring-down method for high-
reflectance and high-transmittance
measurements**

*Optique et photonique — Lasers et équipement associé aux lasers —
Méthode d'alternance de la cavité pour les mesurages du facteur de
réflexion et du facteur de transmission*

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ISO copyright office
CP 401 • Ch. de Blandonnet 8
CH-1214 Vernier, Geneva
Phone: +41 22 749 01 11
Email: copyright@iso.org
Website: www.iso.org

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Foreword

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This document was prepared by ISO/TC 172, *Optics and photonics*, Subcommittee SC 9, *Lasers and electro-optical systems*.

This second edition cancels and replaces the first edition ISO 13142:2015, which has been technically revised.

The main changes compared to the previous edition are as follows:

- addition of transmittance measurements into the document.

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